


Search Notes 	Application/Control No. 10537155	Applicant(s)/Patent Under Reexamination LEE ET AL.
	Examiner O'Reilly III, Patrick F	Art Unit 3749

SEARCHED			
Class	Subclass	Date	Examiner
454	284, 299, 305	12/20/2006	PFO3
62	186	12/20/2006	PFO3
Above	Updated	7/5/2007	PFO3
Above	Updated	2/21/2008	PFO3
239	11, 589.1	2/21/2008	PFO3

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) searched - printout attached.	12/20/2006; 7/5/2007; 2/21/2008	PFO3
PLUS search performed - printout of search results attached.	12/20/2006	STIC
Inventor name search performed in PALM and EAST.	12/19/2006; 12/21/2006	PFO3

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner